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STMicroelectronics STTH810GY-TR

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STTH810-Y

Automotive ultrafast recovery - high voltage diode

Datasheet - production data

Features

- AEC-Q101 qualified
- Ultrafast, soft recovery
- Very low conduction and switching losses
- High frequency and/or high pulsed current operation
- High reverse voltage capability
- High junction temperature

Description

The high quality design of this diode has produced a device with low leakage current, regularly reproducible characteristics and intrinsic ruggedness. These characteristics make it ideal for heavy duty applications that demand long term reliability like automotive applications.

These diodes also fit into auxiliary functions such as snubber, bootstrap, and demagnetization applications.

The improved performance in low leakage current, and therefore thermal runaway guard band, is an immediate competitive advantage for this device.

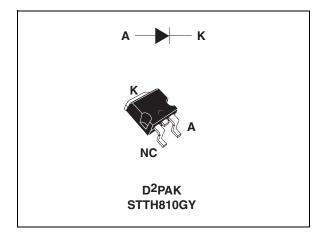


Table 1. Device summary

I _{F(AV)}	8 A
V_{RRM}	1000 V
T _j	175 °C
V _F (typ)	1.30 V
t _{rr} (typ)	47 ns



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Table 2. Absolute ratings (limiting values at 25 °C, unless otherwise specified)

Symbol	Parameter			Value	Unit
V_{RRM}	Repetitive peak reverse voltage			1000	V
I _{F(RMS)}	Forward rms current	Forward rms current			Α
I _{F(AV)}	Average forward current, $\delta = 0.5$ $T_c = 130 ^{\circ}\text{C}$			8	Α
I _{FRM}	Repetitive peak forward current $t_p = 5 \mu s$, $F = 5 kHz square$		100	Α	
I _{FSM}	Surge non repetitive forward current $t_p = 10 \text{ ms sinusoidal}$			60	Α
T _{stg}	Storage temperature range			-65 to + 175	°C
T _j	Operating junction temperature range			-40 to +175	°C

Table 3. Thermal parameters

Symbol	Parameter	Value	Unit
R _{th(j-c)}	Junction to case	2.5	°C/W

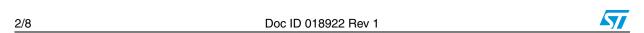
Table 4. Static electrical characteristics

Symbol	Parameter	Test conditions		Min.	Тур.	Max.	Unit
I _R ⁽¹⁾	Reverse leakage current	T _j = 25 °C	V - V			5	
'R`´	neverse leakage current	$T_j = 125 ^{\circ}\text{C}$ $V_R = V_{RRM}$		2	20	μΑ	
		T _j = 25 °C				2	
V _F ⁽²⁾ Forward voltage drop	T _j = 100 °C	I _F = 8 A		1.4	1.8	V	
		T _j = 150 °C			1.3	1.7	

^{1.} Pulse test: $t_p = 5$ ms, $\delta < 2\%$

To evaluate the conduction losses use the following equation:

$$P = 1.3 \times I_{F(AV)} + 0.05 I_{F^{2}(RMS)}^{2}$$



^{2.} Pulse test: t_p = 380 μ s, δ < 2%



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Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t Davis		$I_F = 1 \text{ A, } dI_F/dt = -50 \text{ A/}\mu\text{s,}$ $V_R = 30 \text{ V, } T_j = 25 \text{ °C}$		64	85	ns	
t _{rr}	Reverse recovery time	$I_F = 1 \text{ A, } dI_F/dt = -100 \text{ A/}\mu\text{s,}$ $V_R = 30 \text{ V, } T_j = 25 \text{ °C}$		47	65	113	
I _{RM}	Reverse recovery current	$I_F = 8 \text{ A}, dI_F/dt = -200 \text{ A/}\mu\text{s},$ $V_R = 600 \text{ V}, T_j = 125 ^{\circ}\text{C}$		12	16	Α	
S	Softness factor	$I_F = 8 \text{ A}, dI_F/dt = -200 \text{ A/}\mu\text{s},$ $V_R = 600 \text{ V}, T_j = 125 ^{\circ}\text{C}$		2			
t _{fr}	Forward recovery time	$I_F = 8 \text{ A}$ $dI_F/dt = 50 \text{ A/}\mu\text{s}$ $V_{FR} = 1.5 \text{ x V}_{Fmax}, T_j = 25 \text{ °C}$			300	ns	
V _{FP}	Forward recovery voltage	$I_F = 8 \text{ A, } dI_F/dt = 50 \text{ A/}\mu\text{s,}$ $T_j = 25 ^{\circ}\text{C}$		5.5		٧	

Figure 1. Conduction losses versus average current

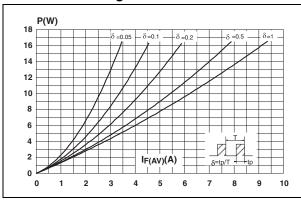


Figure 2. Forward voltage drop versus forward current

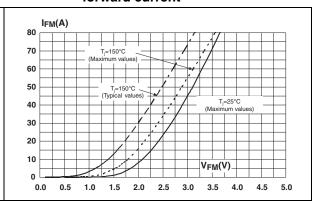


Figure 3. Relative variation of thermal impedance junction to case versus pulse duration

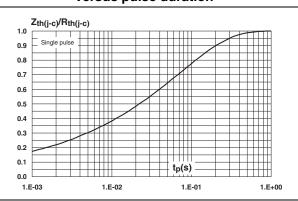
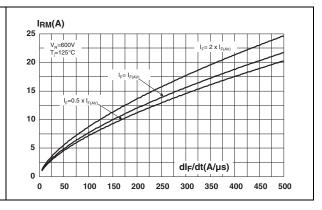


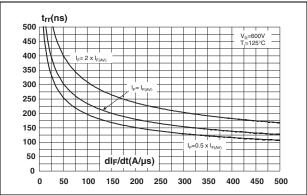
Figure 4. Peak reverse recovery current versus dl_F/dt (typical values)





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Figure 5. Reverse recovery time versus dI_F/dt Figure 6. Reverse recovery charges (typical values) versus dI_F/dt (typical values)



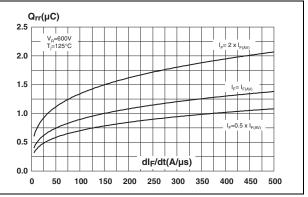
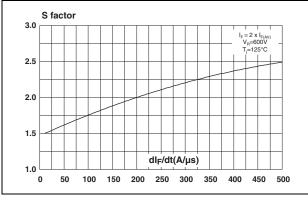


Figure 7. Softness factor versus dl_F/dt (typical values)

Figure 8. Relative variations of dynamic parameters versus junction temperature



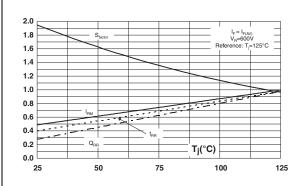
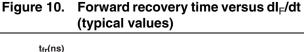
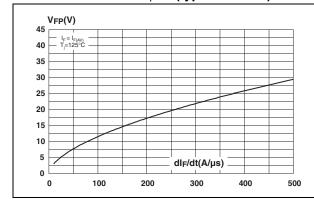
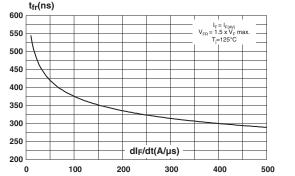


Figure 9. Transient peak forward voltage versus dl_E/dt (typical values)







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Figure 11. Junction capacitance versus reverse voltage applied (typical values)

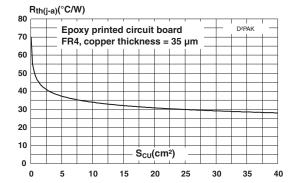
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100

80 Hth(j MHz mm/n_{MMS} 70 55°C 60 40 40 30 20

1000

Figure 12. Thermal resistance junction to ambient versus copper surface under tab





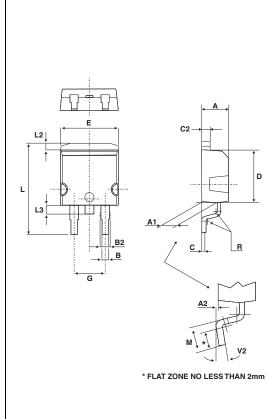
Package information STTH810-Y

2 Package information

- Epoxy meets UL94, V0
- Cooling method: by conduction (C)

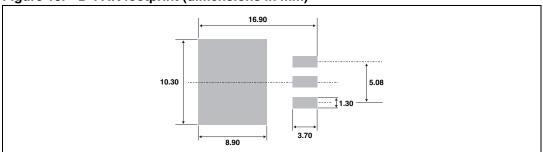
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

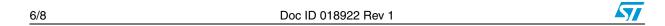
Table 6. D²PAK dimensions



	Dimensions				
Ref.	Millimeters		Inc	hes	
	Min.	Max.	Min.	Max.	
Α	4.40	4.60	0.173	0.181	
A1	2.49	2.69	0.098	0.106	
A2	0.03	0.23	0.001	0.009	
В	0.70	0.93	0.027	0.037	
B2	1.14	1.70	0.045	0.067	
С	0.45	0.60	0.017	0.024	
C2	1.23	1.36	0.048	0.054	
D	8.95	9.35	0.352	0.368	
Е	10.00	10.40	0.393	0.409	
G	4.88	5.28	0.192	0.208	
L	15.00	15.85	0.590	0.624	
L2	1.27	1.40	0.050	0.055	
L3	1.40	1.75	0.055	0.069	
М	2.40	3.20	0.094	0.126	
R	0.40 typ.		0.016	6 typ.	
V2	0°	8°	0°	8°	

Figure 13. D²PAK footprint (dimensions in mm)







STTH810-Y Ordering information

3 Ordering information

Table 7. Ordering information

Order code	Marking	Package	Weight	Base qty	Delivery mode
STTH810GY-TR	STTH810GY	D ² PAK	1.48 g	1000	Tape & reel

4 Revision history

Table 8. Document revision history

Date	Revision	Changes
24-Oct-2012	1	First issue.





Distributor of STMicroelectronics: Excellent Integrated System Limited Datasheet of STTH810GY-TR - DIODE GEN PURP 1KV 8A D2PAK

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STTH810-Y

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